Product data sheet

1 General description

The TJA1443 is a member of the TJA144x family of transceivers that provide an interface between a Controller Area Network (CAN) or CAN FD (Flexible Data rate) protocol controller and the physical two-wire CAN bus. TJA144x transceivers implement the CAN physical layer as defined in ISO 11898-2:2016 and SAE J2284-1 to SAE J2284-5, and are fully interoperable with high-speed Classical CAN and CAN FD transceivers. All TJA144x variants enable reliable communication in the CAN FD fast phase at data rates up to 5 Mbit/s.

The TJA1443 is intended as a simple replacement for high-speed Classical CAN and CAN FD transceivers, such as the TJA1043 from NXP. It offers pin compatibility and is designed to avoid changes to hardware and software design, allowing the TJA1443 to be easily retrofitted to existing applications.

An AEC-Q100 Grade 0 variant, the TJR1443, is available for high temperature applications, supporting operation at 150 °C ambient temperature.

2 Features and benefits

2.1 General

- ISO 11898-2:2016, SAE J2284-1 to SAE J2284-5 and SAE J1939-14 compliant
- Standard CAN and CAN FD data bit rates up to 5 Mbit/s
- Low Electromagnetic Emission (EME) and high Electromagnetic Immunity (EMI)
- Qualified according to AEC-Q100 Grade 1
- VIO input for interfacing with 3.3 V to 5 V microcontrollers
- Listen-only mode for node diagnosis and failure containment
- Available in SO14 and leadless HVSON14 (3.0 mm x 4.5 mm) packages; HVSON14 with improved Automated Optical Inspection (AOI) capability.
- Dark green product (halogen free and Restriction of Hazardous Substances (RoHS) compliant)

2.2 Predictable and fail-safe behavior

- Undervoltage detection with defined handling on all supply pins
- Full functionality guaranteed from the undervoltage detection thresholds up to the maximum limiting voltage values
- Defined behavior below the undervoltage detection thresholds
- Transceiver disengages from the bus (high-ohmic) when the battery voltage drops below the Off mode threshold
- Internal biasing of TXD and mode selection input pins, to enable defined fail-safe behavior



2.3 Low-power management

- Very low-current Standby and Sleep modes, with host, local and bus wake-up capability
- Entire node with TJA1443 can be powered down while still supporting local, bus and host wake-up
- CAN wake-up receiver powered by V_{BAT} allowing V_{IO} and V_{CC} to be shut down
- CAN wake-up pattern filter time of 0.5 μs to 1.8 $\mu s,$ meeting Classical CAN and CAN FD requirements

2.4 Diagnosis & Protection

- Overtemperature diagnosis
- Transmit Data (TXD) dominant time-out and TXD-to-RXD short-circuit handler with diagnosis
- Bus dominant clamping diagnosis
- Cold start diagnosis (first battery connection)
- High ESD handling capability on the bus pins (8 kV IEC and HBM)
- Bus pins and VBAT protected against transients in automotive environments
- Thermally protected

3 Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{BAT}	battery supply voltage		4.5	-	28	V
I _{BAT}	battery supply current	Normal or Listen-only mode	-	80	300	μA
		Standby or Sleep mode	-	13	20	μA
V _{uvd(VBAT)}	undervoltage detection voltage on pin VBAT		4	-	4.5	V
V _{CC}	supply voltage		4.5	-	5.5	V
I _{CC}	supply current	Normal mode, dominant	-	38	60	mA
		Normal mode, recessive	-	4	7	mA
		Listen-only mode	de - 3 5	5	mA	
		Standby or Sleep mode	-	-	2	μA
V _{uvd(VCC)}	undervoltage detection voltage on pin VCC	V _{BAT} > 4.5 V	4	-	4.5	V
V _{uvhys(VCC)}	undervoltage hysteresis voltage on pin VCC		50	-	-	mV
V _{IO}	supply voltage on pin VIO		2.95	-	5.5	V
I _{IO}	supply current on pin VIO	Normal mode, dominant; V _{TXD} = 0 V	-	90	250	μA
		Normal mode, recessive; all other modes; $V_{TXD} = V_{IO}$	-	-	2	μA
V _{uvd(VIO)}	undervoltage detection voltage on pin VIO	V _{BAT} > 4.5 V	2.65	-	2.95	V
V _{uvhys(VIO)}	undervoltage hysteresis voltage on pin VIO		50	-	-	mV
V _{ESD}	electrostatic discharge voltage	IEC 61000-4-2 on pins CANH and CANL	-8	-	+8	kV
V _{CANH}	voltage on pin CANH	limiting value according to IEC 60134	-36	-	+40	V
V _{CANL}	voltage on pin CANL	limiting value according to IEC 60134	-36	-	+40	V
T _{vi}	virtual junction temperature		-40	-	+150	°C

4 Ordering information

Table 2. Ordering information

Type number	Package	Package								
	Name	Description	Version							
TJA1443AT	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1							
TJA1443ATK	HVSON14	plastic thermal enhanced very thin small outline package; no leads; 14 terminals; body 3 × 4.5 × 0.85 mm	SOT1086-2							

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Table 3. TJA1443 feature overview

See Section 19 for a feature overview of the complete TJx144x/TJx146x/TJF1441 family.

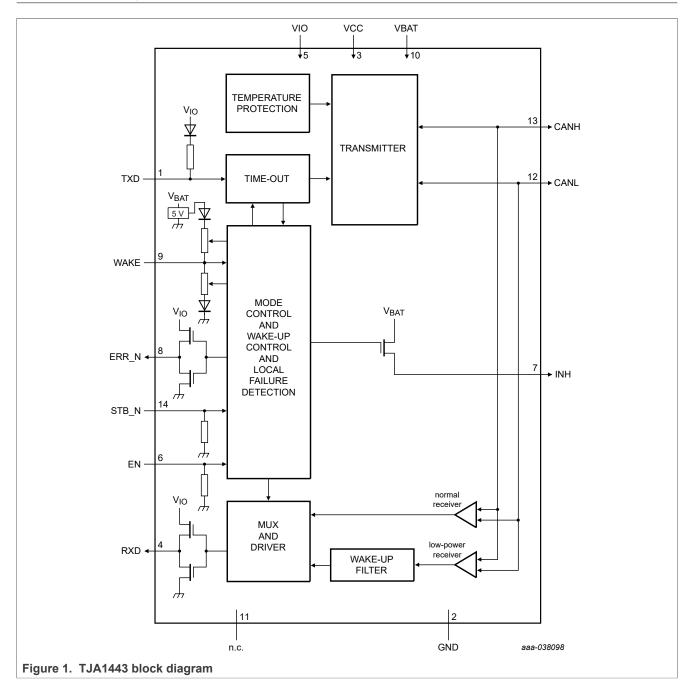
	Modes			Supp	lies		Data rate Additional features									
Device ^[1]	Normal	Standby	Sleep	Silent/Listen-only	Selectable Off	VCC pin	VIO pin	VBAT pin	Up to 5 Mbit/s CAN FD	Up to 8 Mbit/s CAN FD	Signal improvement ^[2]	Wake-up source recognition ^[3]	Short WUP support [0.5 - 1.8 µs] ^[4]	Single supply pin wake-up ^[5]	TXD dominant timeout	Local diagnostics via ERR_N pin
TJA1443A	•	•	•	•		•	•	•	•			•	•	•	•	•

[1] [2] [3] [4] [5] TJA1443 is AEC-Q100 Grade 1.

CAN FD Signal Improvement Capability (SIC) according to CiA 601-4:2019.

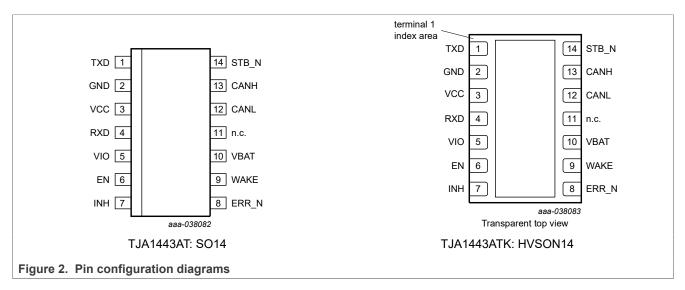
RXD is held LOW after wake-up request, enabling wake-up source recognition. WUP = wake-up pattern according ISO11898-2:2016. Only VBAT supply needed for wake-up.

5 Block diagram



Pinning information 6

6.1 Pinning



6.2 Pin description

Table 4 Pin description

Symbol	Pin	Type ^[1]	Description
TXD	1	I	transmit data input; inputs data (from the CAN controller) to be written to the bus lines
GND ^[2]	2	G	ground
VCC	3	Р	5 V supply voltage input
RXD	4	0	receive data output; outputs data read from the bus lines (to the CAN controller)
VIO	5	Р	supply voltage input for I/O level adapter
EN	6	I	enable control input
INH	7	AO	inhibit output for switching external voltage regulators
ERR_N	8	0	local failure detection; wake-up source recognition and power-on indication output (active-LOW)
WAKE	9	AI	local wake-up input
VBAT	10	Р	battery supply voltage input
n.c.	11	-	not connected
CANL	12	AIO	LOW-level CAN bus line
CANH	13	AIO	HIGH-level CAN bus line
STB_N	14	I	Standby mode control input (active-LOW)

I: digital input; O: digital output; AI: analog input; AO: analog output; AIO: analog input/output; P: power supply; G: ground HVSON14 package die supply ground is connected to both the GND pin and the exposed center pad. The GND pin must be soldered to board ground. For enhanced thermal and electrical performance, it is also recommended to solder the exposed center pad to board ground. [1] [2]

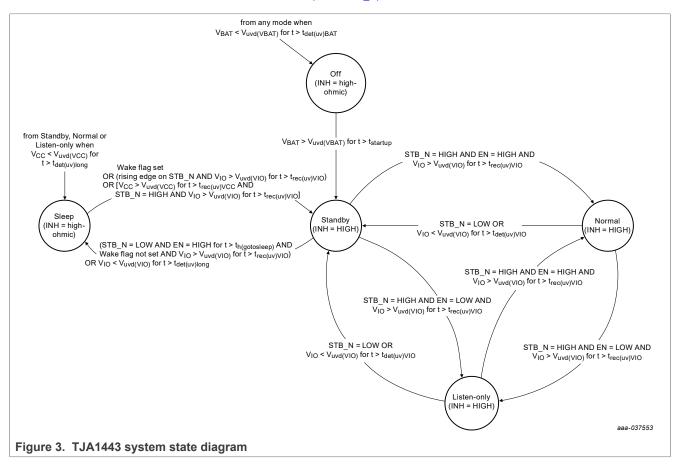
7 Functional description

7.1 Operating modes

The TJA1443 contains two independent state machines, a system state machine and a CAN state machine. Two state machines are needed to secure flag handling during undervoltage conditions. These state machines support a number of interdependent operating modes. The system state machine controls the CAN state machine, but both state machines are independently affected by the V_{CC} undervoltage status. For both state machines, undervoltage detection is defined as V_x < V_{uvd(x)} for t > t_{det(uv)} and undervoltage recovery is defined as V_x > V_{uvd(x)} for t > t_{rec(uv)}.

7.1.1 System operating modes

The system state machine in the TJA1443 supports five system operating modes. Control pins STB_N and EN are used to select the operating mode. Figure 3 describes how to switch between operating modes. Mode changes are completed after transition time $\underline{t_{t(moch)}}$. Fail-safe diagnostic information, as described in Section 7.2, is available on pin ERR_N with a delay of $\underline{t_{d(moch-ERR N)}}$ after a mode change.



7.1.1.1 Off mode

The TJA1443 switches to Off mode from any mode mode when the battery voltage falls below the undervoltage detection threshold, $V_{uvd(VBAT)}$. The device starts up in Off mode

when the battery is connected for the first time (cold start). Pins INH and ERR_N are in a high-ohmic state in Off mode.

7.1.1.2 Standby mode

Standby mode is the first-level power-saving mode of the TJA1443. When V_{BAT} rises above the undervoltage detection threshold, V_{uvd(VBAT)}, the TJA1443 starts to boot up, triggering an initialization procedure. It switches to Standby mode after $t_{startup}$, resulting in a HIGH level on pin INH.

When V_{IO} rises above the undervoltage detection threshold, $V_{uvd(VIO)}$, the TJA1443 switches to Normal mode if pins STB_N and EN are HIGH, and to Listen-only mode if STB_N is HIGH and EN is LOW. It will remain in Standby mode if STB_N is LOW.

The TJA1443 will switch to Sleep mode if V_{IO} remains below V_{uvd(VIO)} for $\underline{t_{det(uv)long}}$ and/or V_{CC} remains below V_{uvd(VCC)} for $t_{det(uv)long}$. A transition from Standby mode to Sleep mode can also be triggered by holding STB_N LOW and EN HIGH for $\underline{t_{h(gotosleep)}}$ (also known as a 'go-to-sleep' command). This 'go-to-sleep' command is overruled if the Wake flag is set, in which case the device remains in Standby mode.

7.1.1.3 Normal mode

HIGH levels on pin STB_N and pin EN selects Normal mode, provided the battery supply voltage, V_{BAT} , and V_{IO} are present. Pin INH remains HIGH, so voltage regulators controlled by pin INH will also be active (see Figure 10).

7.1.1.4 Listen-only mode

A HIGH level on pin STB_N and a LOW level on pin EN selects Listen-only mode, provided V_{BAT} and V_{IO} are present. Pin INH remains HIGH, so voltage regulators controlled by pin INH will also be active.

In Listen-only mode the receiver is enabled, but the transmitter is disabled.

7.1.1.5 Sleep mode

Sleep mode is the second-level power-saving mode of the TJA1443. Sleep mode is entered in a number of ways:

- via Standby mode, in response to a 'go-to-sleep' command
- via Standby mode as a result of a V_{IO} undervoltage longer than t_{det(uv)long}
- via all other modes, except Off mode, as a result of a V_{CC} undervoltage longer than $t_{\text{det}(uv)\text{long}}$

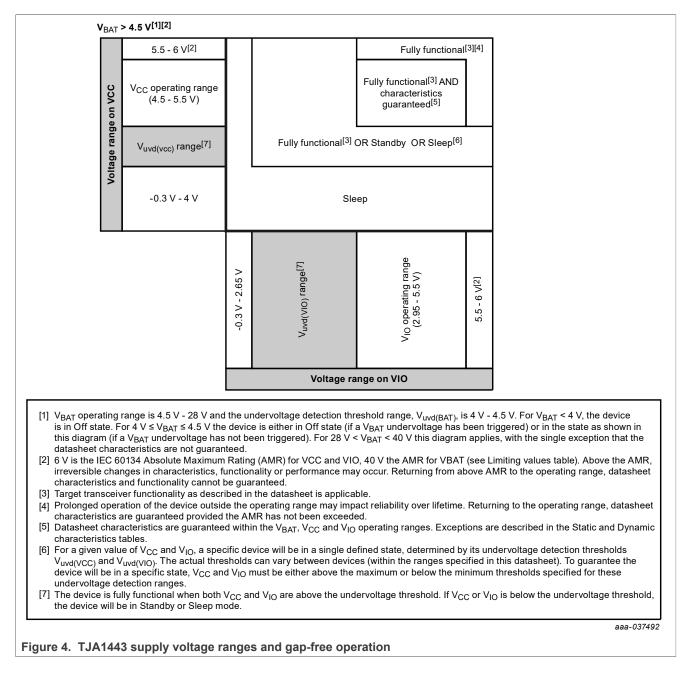
In Sleep mode, the transceiver behaves as described for Standby mode, with the exception that pin INH is set high-ohmic. Voltage regulators controlled by this pin are switched off and the current into pin VBAT is reduced to a minimum.

A number of events will cause the TJA1443 to exit Sleep mode, switching to Standby mode:

- setting the Wake flag
- a rising edge on pin STB_N (if V_{IO} > V_{uvd(VIO)})
- $V_{CC} > V_{uvd(VCC)}$, $V_{IO} > V_{uvd(VIO)}$ and the 'go-to-sleep' command has not been activated. After entering Standby mode, the TJA1443 will enter Normal or Listen-Only if STB_N is HIGH.

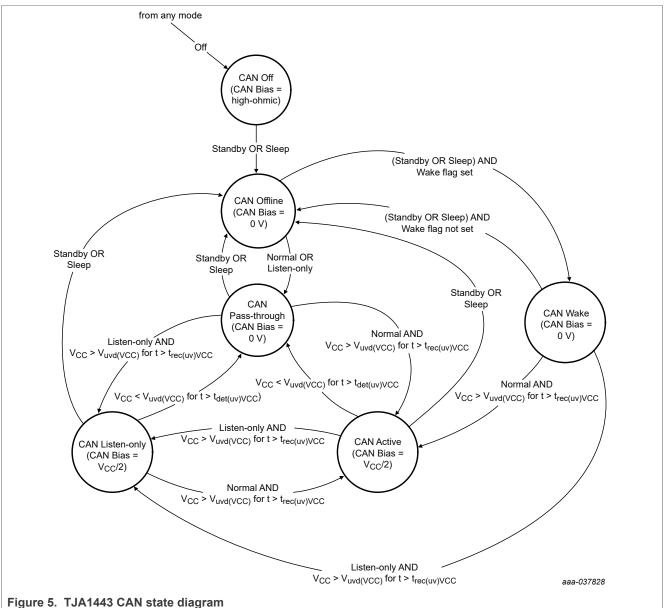
7.1.1.6 System operating modes and gap-free operation

Gap-free operation guarantees defined behavior at all voltage levels. Supply voltage-tooperating mode mapping is detailed in <u>Figure 4</u>.



7.1.2 CAN operating modes

The CAN state machine supports six operating modes.



7.1.2.1 CAN Off mode

When the TJA1443 system state machine is in Off mode, the CAN state machine will be in CAN Off mode, with the bus pins and pin RXD in a high-ohmic state.

7.1.2.2 CAN Offline mode

When the TJA1443 system state machine is in Sleep or Standby mode and the Wake flag has not been set, the CAN state machine will be in CAN Offline mode. The bus pins are biased to ground.

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The transceiver is unable to transmit or receive data and the low-power receiver is activated to monitor the bus for a wake-up pattern. Pin RXD is HIGH.

7.1.2.3 CAN Wake mode

When the TJA1443 system state machine is in Sleep or Standby mode and the wake flag has been set, the CAN state machine will be in CAN Wake mode. Pin RXD will be LOW, reflecting the active wake-up request. The bus pins are biased to ground.

7.1.2.4 CAN Pass-through mode

When the TJA1443 system state machine is in Normal or Listen-only mode and V_{CC} is below the undervoltage detection threshold, $V_{uvd(VCC)}$, the CAN state machine will be in CAN Pass-through mode.

The transceiver cannot transmit data via the bus lines in this mode. The output voltage on the bus pins is biased to ground. Differential data on the bus pins is converted to digital data via the low-power receiver and the results are output on pin RXD.

7.1.2.5 CAN Active mode

When the TJA1443 system state machine is in Normal mode and V_{CC} is above the undervoltage detection threshold, V_{uvd(VCC)}, the CAN state machine will be in CAN Active mode. The transceiver can transmit and receive data via bus lines CANH and CANL. Pin TXD must be HIGH at least once in CAN Active mode before the first transmission can begin. The differential receiver converts the analog data on the bus lines into digital data on pin RXD. In recessive state, the output voltage on the bus pins is V_{CC}/2.

7.1.2.6 CAN Listen-only mode

When the TJA1443 system state machine is in Listen-only mode and V_{CC} is above the undervoltage detection threshold, V_{uvd(VCC)}, the CAN state machine will be in CAN Listen-only mode. The transmitter is disabled. The differential receiver converts the analog data on the bus lines into digital data on pin RXD. As in CAN Active mode, the bus pins are biased to V_{CC}/2.

7.2 Internal flags

The device makes use of four internal flags for fail-safe fallback control and system diagnosis. These flags can be polled by the controller via pin ERR_N while V_{IO} is active. Which flag is available on pin ERR_N at any time depends on the current system operating mode; see Table 5.

Internal flag	Flag available on pin ERR_N ^[1]	Flag status: set ^[2]	Flag status: not set ^[2]	Flag cleared
Pwon	in Listen-only mode (coming from Standby or Sleep mode)	V _{BAT} has risen above V _{uvd(VBAT)}	V_{BAT} has not risen above $V_{uvd(VBAT)}$	on entering Normal mode
Wake	in Standby and Sleep modes (provided V_{IO} and V_{BAT} are present)	remote or local wake-up detected OR Pwon flag has been set	no remote or local wake-up detected	on entering Normal mode
Wake-up source	in Normal mode	local wake-up OR Pwon flag has been set	remote wake-up OR no wake-up	on leaving Normal mode
Local failure	in Listen-only mode (coming from Normal mode)	on occurrence of: - TXD dominant failure OR - TXD-RXD short circuit OR - Bus dominant failure OR - Overtemperature	none of the set conditions have been met	when Pwon flag is set or, provided all local failures have been resolved, when: - device enters Normal mode OR - RXD dominant while TXD recessive OR - bus dominant failure resolved AND no other local failure has set the flag

Table 5. Accessing internal flags via pin ERR_N

[1] Pin ERR_N is an active-LOW output; a LOW level indicates a set flag and a HIGH level indicates the flag has not been set.

[2] Status since flag was last cleared.

7.2.1 Pwon flag

Pwon is the V_{BAT} power-on flag. This flag is set when the voltage on pin VBAT recovers after previously dropping below V_{uvd(VBAT)} (usually because the battery was disconnected). The Pwon flag can be used for cold start diagnosis. The Wake and Wake-up source flags are set to ensure consistent system power-up under all supply conditions. Coming from Sleep or Standby and entering Listen-Only mode, a LOW level on pin ERR_N signals that the Pwon flag has been set. The flag is cleared when the transceiver enters Normal mode.

7.2.2 Wake flag

The Wake flag is set when the transceiver detects a local or remote wake-up request.

7.2.2.1 Local wake-up (via WAKE pin)

A local wake-up request is registered when the logic level on pin WAKE changes and the new level remains stable for at least $\underline{t_{wake}}$. The system state machine can set the Wake flag in Standby or Sleep mode. Setting the Wake flag clears the timers. Once set, the Wake flag status is immediately available on pins ERR_N and RXD (provided V_{IO} and V_{BAT} are present). This flag is also set at power-on and cleared when the transceiver enters Normal mode.

7.2.2.2 Remote wake-up (via the CAN bus)

The TJA1443 wakes up from Sleep to Standby mode when a dedicated wake-up pattern (specified in ISO 11898-2: 2016) is detected on the bus.

The wake-up pattern consists of:

- a dominant phase of at least <u>twake(busdom)</u> followed by
- a recessive phase of at least <u>t_{wake(busrec)}</u> followed by
- a dominant phase of at least t_{wake(busdom)}

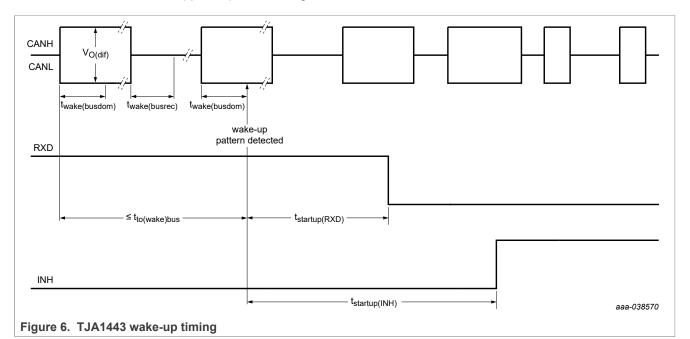
Dominant or recessive bits between the above mentioned phases that are shorter than $t_{wake(busdom)}$ and $t_{wake(busrec)}$ respectively are ignored.

The complete dominant-recessive-dominant pattern must be received within $\underline{t_{to(wake)bus}}$ to be recognized as a valid wake-up pattern (see <u>Figure 6</u>). Otherwise, the internal wake-

up logic is reset. The complete wake-up pattern then needs to be retransmitted to trigger a wake-up event. Pins RXD and ERR_N remain HIGH until the wake-up event has been triggered and then switch LOW after $\underline{t_{startup(RXD)}}$. Pin INH remains floating until the wake-up event has been triggered and then switches HIGH after $\underline{t_{startup(NH)}}$.

A wake-up event is not flagged on RXD if any of the following events occurs while a valid wake-up pattern is being received:

- The device switches to Normal mode
- The complete wake-up pattern was not received within tto(wake)bus
- A V_{CC} or V_{IO} undervoltage is detected



7.2.3 Wake-up source flag

Wake-up source recognition is provided via the Wake-up source flag. It is set after the Wake flag has been set by a local wake-up request via the WAKE pin. The Wake-up source flag can be polled via the ERR_N pin in Normal mode (see <u>Table 5</u>). This flag is also set at power-on and cleared when the transceiver leaves Normal mode.

7.2.4 Local failure flag

In Normal and Listen-only modes, the transceiver can distinguish four local failure events, any of which will cause the Local failure flag to be set. The four local failure events are:

- TXD dominant failures
- TXD-to-RXD short circuit
- Bus dominant failures
- Overtemperature

The nature and detection of these local failures is described in <u>Section 7.3</u>. The Local failure flag can be polled via the ERR_N pin in Listen-only mode, when coming from Normal mode (see <u>Table 5</u>).

This flag is cleared at power-on when the Pwon flag is set or, provided all local failures have been resolved, when:

- The device enters Normal mode OR
- RXD is dominant while TXD is recessive OR
- Bus dominant failure has been resolved AND no other local failure has set the flag

7.3 Local failure events

The TJA1443 can detect four different local failure conditions, any of which will set the Local failure flag. In most cases, the transmitter is disabled.

7.3.1 TXD dominant failures

A hardware and/or software application failure that caused pin TXD to be held LOW would drive the bus lines to a permanent dominant state (blocking all network communications). The TXD dominant time-out function prevents such a network lock-up. A 'TXD dominant time-out' timer is started when pin TXD goes LOW. If the LOW state on this pin persists for longer than $\underline{t}_{to(dom)TXD}$, the transmitter is disabled, releasing the bus lines to recessive state. The transmitter remains disabled until the Local failure flag has been cleared. The TXD dominant time-out timer is reset when pin TXD is set HIGH.

7.3.2 TXD-to-RXD short circuit

A short-circuit between pins RXD and TXD would lock the bus in a permanent dominant state once it had been driven dominant, because the low-side driver of RXD is typically stronger than the high-side driver of the controller connected to TXD. TXD-to-RXD short-circuit detection prevents such a network lock-up by disabling the transmitter. The transmitter remains disabled until the Local failure flag has been cleared.

7.3.3 Bus dominant failures

A CAN bus short circuit (to V_{BAT} , V_{CC} or GND) or a failure in one of the other network nodes could result in a differential voltage on the bus high enough to represent a bus dominant state. Because a node will not begin to transmit while the bus is dominant, the host controller would not be able to detect this failure condition. However, bus dominant clamping detection will detect the short circuit. The Local failure flag is set if the dominant state on the bus persists for longer than $\underline{t}_{to(dom)bus}$. By checking this flag, the controller can determine if a clamped bus is blocking network communications. There is no need to disable the transmitter. Note that the Local failure flag is reset as soon as the bus returns to recessive state.

7.3.4 Overtemperature

The device is protected against overtemperature conditions. If the junction temperature exceeds the shutdown junction temperature, $T_{j(sd)}$, the CAN bus drivers are disabled. The transmitter will remain disabled until the junction temperature drops below $T_{j(sd)rel}$ and the Local failure flag has been cleared.

7.4 I/O levels

Pin VIO should be connected to the same supply voltage used to supply the microcontroller. This adjusts the signal levels on pins TXD, RXD, STB_N, EN and

ERR_N to the I/O levels of the microcontroller, allowing for direct interfacing without additional glue logic. Spurious signals from the microcontroller on pins STB_N and EN are filtered out with a filter time of $\underline{t_{fltr(IO)}}$.

7.5 WAKE pin

A local wake-up event is triggered by a LOW-to-HIGH or HIGH-to-LOW transition on the WAKE pin when V_{WAKE} passes the wake-up threshold, V_{th(wake)}. After the transition, the new HIGH or LOW level should remain stable for at least t_{wake}. This allows for maximum flexibility when designing a local wake-up circuit.

A local wake-up is guaranteed in the case of:

- a LOW-to-HIGH transition from V_{WAKE} < V_{th(wake)min} to V_{WAKE} > V_{th(wake)max}, followed by V_{WAKE} > V_{th(wake)max} for t > t_{wake(max)}

- a HIGH-to-LOW transition from $V_{WAKE} > V_{th(wake)max}$ to $V_{WAKE} < V_{th(wake)min}$, followed by $V_{WAKE} < V_{th(wake)min}$ for t > t_{wake(max)}

A local wake-up is guaranteed not to occur if the HIGH/LOW level after the transition does not remain stable for at least $t_{(wake)min}$.

To minimize current consumption, the internal bias voltage follows the logic state on the pin after a delay of t_{wake} . A HIGH level on pin WAKE is followed by an internal pull-up to V_{BAT} . A LOW level on pin WAKE is followed by an internal pull-down towards GND. In applications that do not make use of the local wake-up facility, it is recommended to connect the WAKE pin to pin VBAT or GND for optimal EMI performance.

7.6 Internal biasing of TXD, STB_N and EN input pins

Pin TXD has an internal pull-up to V_{IO} and pins STB_N and EN have internal pull-downs to GND to ensure a safe, defined state in case one, or all, of these pins is left floating. Pull-up/pull-down resistors are present on these pins in all states. Pull-down on pin EN is only active when V_{BAT} is present.

Limiting values 8

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134); all voltages are referenced to pin GND, unless otherwise specified; positive currents flow into the IC.

Symbol	Parameter	Conditions		Min	Мах	Unit
V _x	Voltage on pin x ^[1]	pins VCC, VIO, TXD, STB_N, EN		-0.3	+6	V
				-	+7 ^[2]	V
		pin VBAT, load dump		-0.3	+40 ^[3]	V
		pin INH		-0.3	V _{BAT} +0.3 ^[4]	V
		pins CANH, CANL, WAKE		-36	+40	V
		pins RXD, ERR_N		-0.3	V _{IO} +0.3 ^[5]	V
I _{O(INH)}	output current on pin INH			-2	-	mA
V _(CANH-CANL)	voltage between pin CANH and pin CANL			-40	+40	V
V _{trt}	transient voltage	on pins VBAT, WAKE, CANH, CANL	[6]			
		pulse 1		-100	-	V
		pulse 2a		-	+75	V
		pulse 3a		-150	-	V
		pulse 3b		-	+100	V
V _{ESD}	electrostatic discharge	IEC 61000-4-2 (150 pF, 330 Ω discharge circuit)	[7]			
	voltage	on pins CANH, CANL; pin VBAT with 100 nF capacitor; pin WAKE with 33 $k\Omega$ resistor		-8	+8	kV
		Human Body Model (HBM)				
		on any pin	[8]	-4	+4	kV
		on pins CANH, CANL	[9]	-8	+8	kV
		Charged Device Model (CDM)	[10]			
		on corner pins		-750	+750	V
		on any other pin		-500	+500	V
T _{vj}	virtual junction temperature		[11]	-40	+150	°C
T _{stg}	storage temperature		[12]	-55	+150	°C

The device can sustain voltages up to the specified values over the product lifetime, provided applied voltages (including transients) never exceed these [1] values.

[2] [3] The device can withstand voltages between 6 V and 7 V for a total of 20 s over the product lifetime.

For a maximum of 50 hours over the product lifetime.

Absolute maximum of 40 V under the conditions defined in Table note 3 above. [4] [5] [6]

Subject to the qualifications detailed in Table notes 1 and 2 above for pins VCC, VIO, TXD, STB_N and EN. Verified by an external test house according to IEC TS 62228, Section 4.2.4; parameters for standard pulses defined in ISO 7637, Part 2. Verified by an external test house according to IEC TS 62228, Section 4.3.

[7]

According to AEC-Q100-002. [8]

Pins stressed to reference group containing all ground and supply pins, emulating the application circuits (Figure 10). HBM pulse as specified in AEC-[9] Q100-002 used

[10] According to AEC-Q100-011.

In accordance with IEC 60747-1. An alternative definition of virtual junction temperature is: $T_{vj} = T_{amb} + P \times R_{th(j-a)}$, where $R_{th(j-a)}$ is a fixed value used in the calculation of T_{vj} . The rating for T_{vj} limits the allowable combinations of power dissipation (P) and ambient temperature (T_{amb}). T_{stg} in application according to IEC61360-4. For component transport and storage conditions, see instead IEC61760-2. [11]

[12]

TJA1443

9 Thermal characteristics

Table 7. Thermal characteristics

Value determined for free convection conditions on a JEDEC 2S2P board.

Symbol	Parameter	Conditions ^[1]	Тур	Unit
R _{th(j-a)}	thermal resistance from junction to ambient		83	K/W
		HVSON14	54	K/W
R _{th(j-c)}	thermal resistance from junction to case ^[2]	HVSON14	21	K/W
Ψ_{j-top}	thermal characterization parameter from junction to top of package	SO14	19	K/W
		HVSON14	11	K/W

[1] According to JEDEC JESD51-2, JESD51-5 and JESD51-7 at natural convection on 2s2p board. Board with two inner copper layers (thickness: 35 µm) and thermal via array under the exposed pad connected to the first inner copper layer (thickness: 70 µm).

[2] Case temperature refers to the center of the heatsink at the bottom of the package.

10 Static characteristics

Table 8. Static characteristics

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V; V_{BAT} = 4.5 V to 28 V; R_L = 60 Ω unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC.^[1]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Supply; p	in VCC	·	I	I]
V _{CC}	supply voltage		4.5	-	5.5	V
V _{uvd}	undervoltage detection voltage		[2] 4	-	4.5	V
V _{uvhys}	undervoltage hysteresis voltage		50	-	-	mV
I _{CC}	supply current	Normal mode				
		dominant; V _{TXD} = 0 V; t < t _{to(dom)TXD}	-	38	60	mA
		dominant; V _{TXD} = 0 V; short circuit on bus lines; -3 V < (V _{CANH} = V _{CANL}) < +40 V	-	-	125	mA
		Normal mode, recessive; $V_{TXD} = V_{IO}$	-	4	7	mA
		Listen-only mode	-	3	5	mA
		Standby or Sleep mode; T _{vj} < 85 °C	-	-	2	μA
I/O level a	adapter supply; pin VIO					
V _{IO}	supply voltage		2.95	-	5.5	V
V _{uvd}	undervoltage detection voltage		[2] 2.65	-	2.95	V

	5					
V _{uvhys}	undervoltage hysteresis voltage		50	-	-	mV
I _{IO}	supply current	Normal mode, dominant; V _{TXD} = 0 V	-	90	250	μA
		Normal mode, recessive, $V_{TXD} = V_{IO}$ or Listen-only mode	-	-	2	μA

Table 8. Static characteristics...continued

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V; V_{BAT} = 4.5 V to 28 V; R_L = 60 Ω unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC.^[1]

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
		Standby or Sleep mode; T _{vj} < 85 °C	-	-	2	μA
Supply; pin	VBAT				1	
V _{BAT}	battery supply voltage		4.5	-	28	V
V _{uvd}	undervoltage detection voltage]	^{2]} 4	-	4.5	V
I _{BAT}	battery supply current	Normal or Listen-only mode; pin INH left open	-	80	300	μΑ
		Normal or Listen-only mode; pin INH left open; $T_{vj} \le 25 \text{ °C}$; $V_{BAT} = 14.5 \text{ V}$	-	80	100	μA
		Standby mode; pin INH left open; V_{WAKE} = V_{BAT} ; T_{vj} < 85 °C	-	13	20	μA
		Sleep mode; V _{WAKE} = V _{BAT} ; T _{vj} < 85 °C	-	13	20	μA
CAN trans	mit data input; pin TXD					,
V _{IH}	HIGH-level input voltage		0.7V	ю -	-	V
V _{IL}	LOW-level input voltage		-	-	0.3V _{IO}	V
V _{hys(TXD)}	hysteresis voltage on pin TXD		50	-	-	mV
R _{pu}	pull-up resistance		20	-	80	kΩ
Ci	input capacitance	1	3] _	-	10	pF
CAN receiv	ve data output; pin RXD					
I _{ОН}	HIGH-level output current	$V_{RXD} = V_{IO} - 0.4 V$	-10	-	-1	mA
I _{OL}	LOW-level output current	V _{RXD} = 0.4 V	1	-	10	mA
Standby ar	nd enable control inputs; pins S	TB_N and EN				
V _{IH}	HIGH-level input voltage		0.7V	ю -	-	V
V _{IL}	LOW-level input voltage		-	-	0.3V _{IO}	V
V _{hys}	hysteresis voltage		50	-	-	mV
R _{pd}	pull-down resistance	[^{4]} 20	-	80	kΩ
C _i	input capacitance]	3] -	-	10	pF
Local failur	e detection and power-on indi	cation output; pin ERR_N				
I _{OH}	HIGH-level output current	$V_{\text{ERR}_N} = V_{\text{IO}} - 0.4 \text{ V}$	-50	-	-4	μA
I _{OL}	LOW-level output current	V _{ERR_N} = 0.4 V	0.1	-	2	mA
Local wake	e-up input; pin WAKE					,
R _{pu}	pull-up resistance	$V_{WAKE} > V_{th(wake)(max)}$ for t > t _{wake(max)}	100	-	400	kΩ
R _{pd}	pull-down resistance	$V_{WAKE} < V_{th(wake)(min)}$ for t > t _{wake(max)}	100	-	400	kΩ
V _{th(wake)}	wake-up threshold voltage	Sleep or Standby mode	1.8	-	2.6	V
V _{hys}	hysteresis voltage		90	-	-	mV
					1	

Table 8. Static characteristics...continued

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V; V_{BAT} = 4.5 V to 28 V; R_L = 60 Ω unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC.^[1]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Inhibit outp	out; pin INH						
ΔV _H	HIGH-level voltage drop	$\Delta V_{H} = V_{BAT} - V_{INH}; I_{INH} = -1 \text{ mA}$		0	-	1	V
		$\Delta V_{H} = V_{BAT} - V_{INH}; I_{INH} = -2 \text{ mA}$		0	-	2	V
IL	leakage current	Sleep mode; Off mode		-2	-	+2	μA
I _{O(sc)}	short-circuit output current	V _{INH} = 0 V		-15	-	-	mA
Bus lines;	pins CANH and CANL				1		
V _{O(dom)}	dominant output voltage	V_{TXD} = 0 V; t < t _{to(dom)TXD} ; $V_{CC} \ge 4.75$ V					
		pin CANH; R_L = 50 Ω to 65 Ω		2.75	3.5	4.5	V
		pin CANL; R_L = 50 Ω to 65 Ω		0.5	1.5	2.25	V
V _{TXsym}	transmitter voltage symmetry	VIXSVM VCANH VCANL, VSPLII III,	[3] [5]	0.9V _{CC}	-	1.1V _{CC}	V
V _{cm(step)}	common mode voltage step		[3] [5] [6]	-150	-	+150	mV
V _{cm(p-p)}	peak-to-peak common mode voltage		[3] [5] [6]	-300	-	+300	mV
V _{O(dif)}	differential output voltage	dominant; Normal mode; $V_{TXD} = 0 V$; t < $t_{to(dom)TXD}$; $V_{CC} \ge 4.75 V$	[5]				
		R_L = 50 Ω to 65 Ω		1.5	-	3	V
		R_L = 45 Ω to 70 Ω		1.4	-	3.3	V
		R _L = 2240 Ω	[3]	1.5	-	5	V
		recessive; no load					
		Normal or Listen-only mode; $V_{TXD} = V_{IO}$		-50	-	+50	mV
		Standby or Sleep mode		-0.2	-	+0.2	V
V _{O(rec)}	recessive output voltage	Normal or Listen-only mode; V _{TXD} = V _{IO} ; no load		2	2.5	3	V
		Standby or Sleep mode; no load		-0.1	0	+0.1	V
$V_{th(RX)dif}$	differential receiver threshold voltage	$\begin{array}{l} -12 \ V \leq V_{CANH} \leq +12 \ V; \\ -12 \ V \leq V_{CANL} \leq +12 \ V \end{array}$					
		Normal or Listen-only mode		0.5	-	0.9	V
		Standby or Sleep mode		0.4	-	1.1	V
V _{rec(RX)}	receiver recessive voltage	$\begin{array}{l} -12 \ V \leq V_{CANH} \leq +12 \ V; \\ -12 \ V \leq V_{CANL} \leq +12 \ V \end{array}$					
		Normal or Listen-only mode		-4	-	+0.5	V
		Standby or Sleep mode		-4	-	+0.4	V
V _{dom(RX)}	receiver dominant voltage	$\begin{array}{l} -12 \ V \leq V_{CANH} \leq +12 \ V; \\ -12 \ V \leq V_{CANL} \leq +12 \ V \end{array}$					

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Table 8. Static characteristics...continued

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V; V_{BAT} = 4.5 V to 28 V; R_{I} = 60 Ω unless specified otherwise; all voltages are defined with respect to ground; positive currents flow into the IC.^[1]

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
		Normal or Listen-only mode	0.9	-	9	V
		Standby or Sleep mode	1.1	-	9	V
V _{hys(RX)dif}	differential receiver hysteresis voltage	-12 V \leq V _{CANH} \leq +12 V; -12 V \leq V _{CANL} \leq +12 V; Normal or Listen- only mode	50	-	-	mV
I _{O(sc)}	short-circuit output current	$\begin{array}{l} -15 \ V \leq V_{CANH} \leq +40 \ V; \\ -15 \ V \leq V_{CANL} \leq +40 \ V \end{array}$	-	-	115	mA
I _{O(sc)} rec	recessive short-circuit output current	-27 V \leq V _{CANH} \leq +32 V; -27 V \leq V _{CANL} \leq +32 V; Normal or Listen- only mode; V _{TXD} = V _{IO}	-3	-	+3	mA
lL	leakage current	$V_{CC} = V_{IO} = 0$ V or pins shorted to GND via 47 K Ω ; $V_{CANH} = V_{CANL} = 5$ V;	-10	-	+10	μA
R _i	input resistance	$-2 \text{ V} \leq \text{V}_{\text{CANL}} \leq +7 \text{ V}; -2 \text{ V} \leq \text{V}_{\text{CANH}} \leq +7 \text{ V}$	25	40	50	kΩ
ΔR _i	input resistance deviation	$0 V \le V_{CANL} \le +5 V$; $0 V \le V_{CANH} \le +5 V$	-3	-	+3	%
R _{i(dif)}	differential input resistance	$-2 \text{ V} \leq \text{V}_{\text{CANL}} \leq +7 \text{ V}; -2 \text{ V} \leq \text{V}_{\text{CANH}} \leq +7 \text{ V}$	50	80	100	kΩ
C _{i(cm)}	common-mode input capacitance	[3] -	-	20	pF
C _{i(dif)}	differential input capacitance	[3] -	-	10	pF
Temperatu	re detection					
T _{j(sd)}	shutdown junction temperature	[3	[]] 180	-	200	°C
T _{j(sd)rel}	release shutdown junction temperature	[3	[]] 175	-	195	°C

All parameters are guaranteed over the virtual junction temperature range by design. Factory testing uses correlated test conditions to cover the specified [1] Undervoltage is detected between min and max values. Undervoltage is guaranteed to be detected below min value and guaranteed not to be detected

[2] above max value.

Not tested in production; guaranteed by design. [3]

Pull-down on EN pin is only active when V_{BAT} is present. The test circuit used to measure the bus output voltage symmetry and the common-mode voltages (which includes C_{SPLIT}) is shown in Figure 12. [4] [5]

See Figure 9. [6]

11 Dynamic characteristics

Table 9. Dynamic characteristics

 T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V; V_{BAT} = 4.5 V to 28 V; R_L = 60 Ω unless specified otherwise; all voltages are defined with respect to ground.^[1]

Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
CAN timing cl	naracteristics; t _{bit(TXD)} ≥ 200 ns; see <mark>Figure</mark>	7, Figure 8 and Figure 11					
t _{d(TXD-busdom)}	delay time from TXD to bus dominant	Normal mode		-	-	102.5	ns
t _{d(TXD-busrec)}	delay time from TXD to bus recessive	Normal mode		-	-	102.5	ns
t _{d(busdom-RXD)}	delay time from bus dominant to RXD	Normal or Listen-Only mode		-	-	115	ns
t _{d(busrec-RXD)}	delay time from bus recessive to RXD	Normal or Listen-Only mode		-	-	115	ns
t _{d(TXDL-RXDL)}	delay time from TXD LOW to RXD LOW	Normal mode		-	-	215	ns
t _{d(TXDH-RXDH)}	delay time from TXD HIGH to RXD HIGH	Normal mode		-	-	215	ns
CAN FD timin	g characteristics according to ISO 11898-2:	2016; see <u>Figure 8</u> and <u>Figure 11</u>					
t _{bit(bus)}	transmitted recessive bit width	t _{bit(TXD)} = 500 ns		435	-	530	ns
		t _{bit(TXD)} = 200 ns		155	-	210	ns
Δt _{rec}	receiver timing symmetry	t _{bit(TXD)} = 500 ns		-65	-	+40	ns
		t _{bit(TXD)} = 200 ns		-45	-	+15	ns
t _{bit(RXD)}	bit time on pin RXD	t _{bit(TXD)} = 500 ns		400	-	550	ns
		t _{bit(TXD)} = 200 ns		120	-	220	ns
Dominant time	e-out times						
<u>t_{to(dom)}TXD</u>	TXD dominant time-out time	V _{TXD} = 0 V; Normal mode	[2] [3]	0.8	-	9	ms
<u>t</u> to(dom)bus	bus dominant time-out time	V _{O(dif)} > 0.9 V; Normal or Listen-		0.8	-	9	ms
Bus wake-up	times; pins CANH and CANL; see Figure 6]
<u>twake(busdom)</u>	bus dominant wake-up time	Standby or Sleep mode	[2] [4]	0.5	-	1.8	μs
<u>t</u> wake(busrec)	bus recessive wake-up time	Standby or Sleep mode	[2] [4]	0.5	-	1.8	μs
t <u>to(wake)bus</u>	bus wake-up time-out time	Standby or Sleep mode	[2] [3]	0.8	-	9	ms
Mode transitio	DNS						
t _{t(moch)}	mode change transition time		[2]	-	-	50	μs
t_startup	start-up time		[2]	-	-	1	ms
t <u>startup(RXD)</u>	RXD start-up time	after local or remote wake-up detected	[2] [5]	4	-	20	μs
<u>t_{startup}(INH)</u>	INH start-up time	after local or remote wake-up detected; transition from Sleep to Standby	[2] [6]	4	-	50	μs

Table 9. Dynamic characteristics...continued

T_{vj} = -40 °C to +150 °C; V_{CC} = 4.5 V to 5.5 V; V_{IO} = 2.95 V to 5.5 V; V_{BAT} = 4.5 V to 28 V; R_L = 60 Ω unless specified otherwise; all voltages are defined with respect to ground.^[1]

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
<u>th(gotosleep)</u>	go-to-sleep hold time	STB_N = LOW and EN = HIGH hold time for entering Sleep mode	[2] [7]	24	-	50	μs
t_d(moch-ERR_N)	delay time from mode change to ERR_N	to ERR_N stable after mode transition	[2]	-	-	20	μs
Local wake-u	p input; pin WAKE	1					
<u>t_{wake}</u>	wake-up time	in response to a falling or rising edge on pin WAKE; Standby or Sleep mode	[8]	20	-	50	μs
IO filter; pins	STB_N, EN	·					
<u>t_{fltr(IO)}</u>	I/O filter time		[9]	1	-	5	μs
Undervoltage	detection; see <u>Figure 3</u> and <u>Figure 5</u>	1			-1		
t _{det(uv)}	undervoltage detection time	on pin VBAT	[2]	-	-	30	μs
		on pin VCC	[2]	-	-	30	μs
		on pin VIO	[2]	-	-	30	μs
<u>t_{det(uv)long}</u>	long undervoltage detection time	on pins VCC and/or VIO	[2] [10]	100	-	150	ms
t _{rec(uv)}	undervoltage recovery time	on pin VCC	[2]	-	-	50	μs
		on pin VIO	[2]	-	-	50	μs

[1] All parameters are guaranteed over the junction temperature range by design. Factory testing uses correlated test conditions to cover the specified temperature and power supply voltage range.

[2] Not tested in production; guaranteed by design.

[3] Time-out occurs between the min and max values. Time-out is guaranteed not to occur below the min value; time-out is guaranteed to occur above the max value.

[4] A dominant/recessive phase shorter than the min value is guaranteed not be seen as a dominant/recessive bit; a dominant/recessive phase longer than the max value is guaranteed to be seen as a dominant/recessive bit.

[5] When a wake-up is detected, RXD start-up time is between the min and max values. RXD cannot be relied on below the min value; RXD can be relied on above the max value; see Figure 6.

[6] INH switches HIGH between the min and max values after a wake-up had been detected. INH is guaranteed to be floating below the min value and guaranteed to be HIGH above the max value; see Figure 6.

[7] The device is guaranteed to switch to Sleep mode when STB_N = LOW and EN = HIGH for longer than max value, and guaranteed not to switch to Sleep mode when less than the min value.

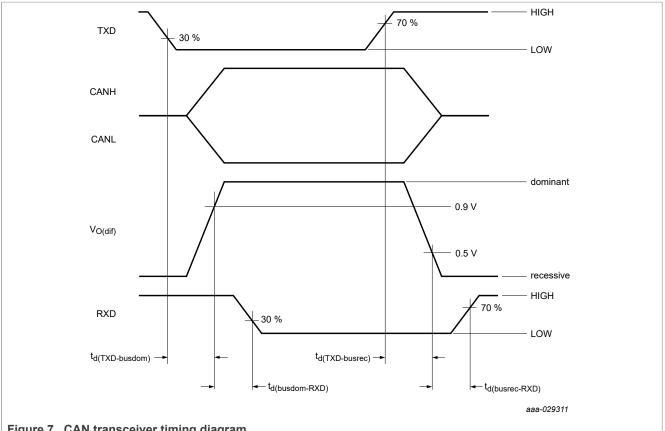
[8] The device is guaranteed to wake up above 50 µs and guaranteed not to wake up below 20 µs.

9 Pulses shorter than the min value are guaranteed to be filtered out; pulses longer than the max value are guaranteed to be processed.

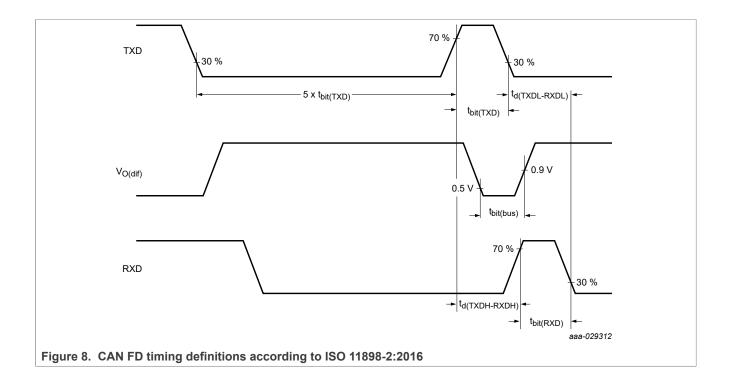
[10] An undervoltage longer than the max value is guaranteed to force a transition to Sleep mode; an undervoltage shorter than the min value is guaranteed not to force a transition to Sleep mode.

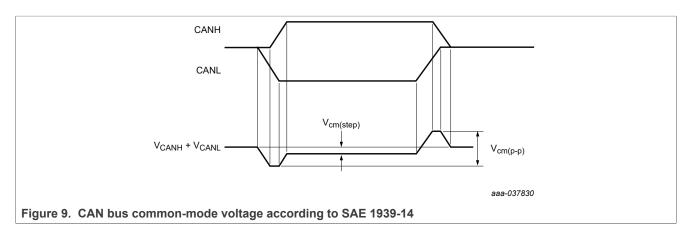
TJA1443

High-speed CAN transceiver with Sleep mode



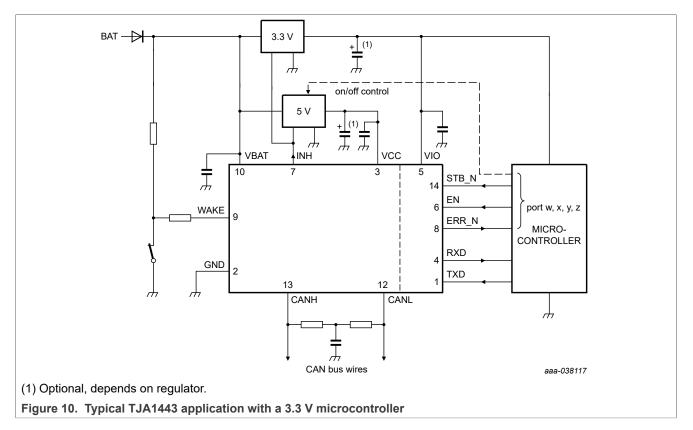






12 Application information

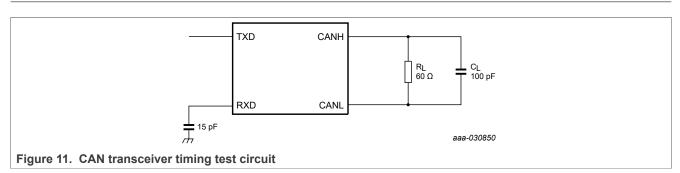
12.1 Application diagram

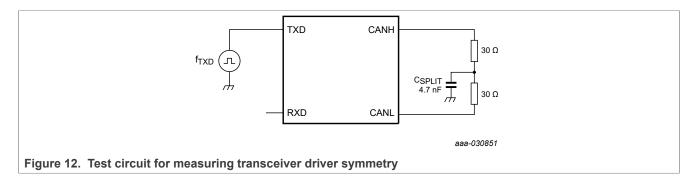


12.2 Application hints

Further information on the application of the TJA1443 can be found in NXP application hints AH2002 '*TJx144x/TJx146x Application Hints*', available on request from NXP Semiconductors.

13 Test information

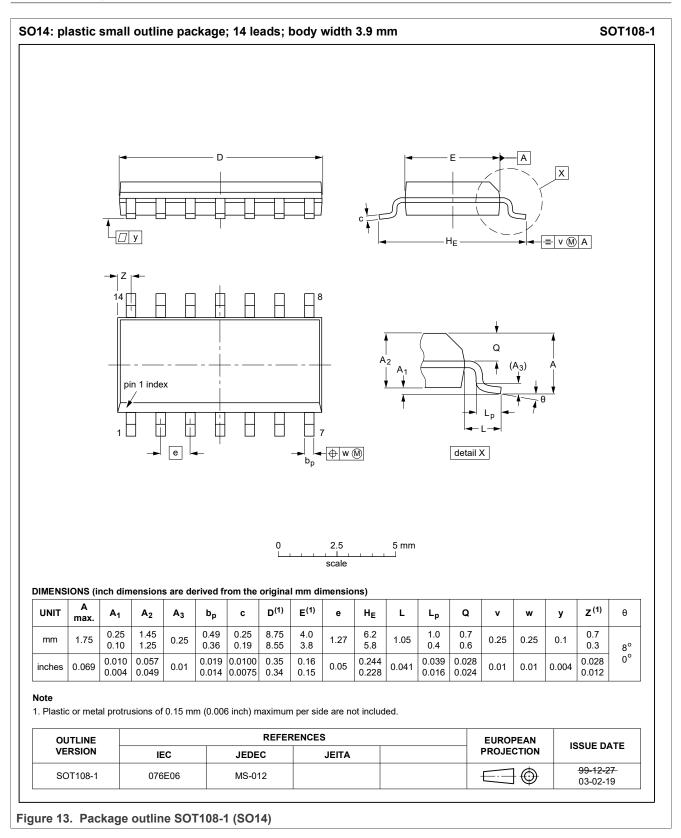


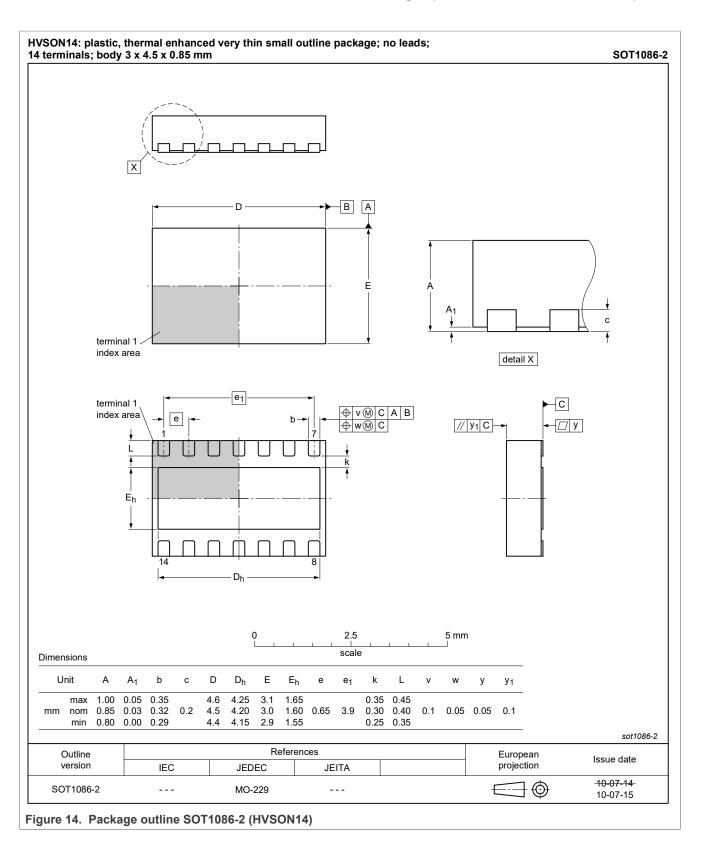


13.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q100 Rev-H - Failure mechanism based stress test qualification for integrated circuits*, and is suitable for use in automotive applications.

14 Package outline





15 Handling information

All input and output pins are protected against ElectroStatic Discharge (ESD) under normal handling. When handling ensure that the appropriate precautions are taken as described in *JESD625-A* or equivalent standards.

16 Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365 "Surface mount reflow soldering description"*.

16.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

16.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- · Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- Board specifications, including the board finish, solder masks and vias
- Package footprints, including solder thieves and orientation
- · The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- · Lead-free soldering versus SnPb soldering

16.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- · Solder bath specifications, including temperature and impurities

16.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 15</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with <u>Table 10</u> and <u>Table 11</u>

Table 10. SnPb eutectic process (from J-STD-020D)

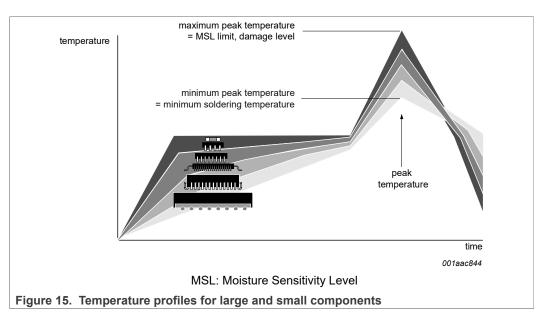
Package thickness (mm)	Package reflow temperature (°C) Volume (mm ³)				
	< 350	≥ 350			
< 2.5	235	220			
≥ 2.5	220	220			

Table 11. Lead-free process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)						
	Volume (mm ³)						
	< 350	350 to 2000	> 2000				
< 1.6	260	260	260				
1.6 to 2.5	260	250	245				
> 2.5	250	245	245				

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see <u>Figure 15</u>.



For further information on temperature profiles, refer to Application Note *AN10365 "Surface mount reflow soldering description"*.

17 Soldering of HVSON packages

<u>Section 16</u> contains a brief introduction to the techniques most commonly used to solder Surface Mounted Devices (SMD). A more detailed discussion on soldering HVSON leadless package ICs can be found in the following application note:

• AN10365 "Surface mount reflow soldering description"

18 Appendix: ISO 11898-2:2016 parameter cross-reference list

ISO 11898-2:2016		NXP data sheet			
Parameter	Notation	Symbol	Parameter		
HS-PMA dominant output characteristics					
Single ended voltage on CAN_H	V _{CAN_H}	V _{O(dom)}	dominant output voltage		
Single ended voltage on CAN_L	V _{CAN_L}	_			
Differential voltage on normal bus load	V _{Diff}	V _{O(dif)}	differential output voltage		
Differential voltage on effective resistance during arbitration					
Optional: Differential voltage on extended bus load range					
HS-PMA driver symmetry					
Driver symmetry	V _{SYM}	V _{TXsym}	transmitter voltage symmetry		
Maximum HS-PMA driver output current	•				
Absolute current on CAN_H	I _{CAN_H}	I _{O(sc)}	short-circuit output current		
Absolute current on CAN_L	I _{CAN_L}				
HS-PMA recessive output characteristics, bus biasing ac	ctive/inactiv	ve			
Single ended output voltage on CAN_H	V _{CAN_H}	V _{O(rec)}	recessive output voltage		
Single ended output voltage on CAN_L	V _{CAN_L}				
Differential output voltage	V _{Diff}	V _{O(dif)}	differential output voltage		
Optional HS-PMA transmit dominant time-out					
Transmit dominant time-out, long	t _{dom}	t _{to(dom)TXD}	TXD dominant time-out time		
Transmit dominant time-out, short	-				
HS-PMA static receiver input characteristics, bus biasing	g active/ina	active			
Recessive state differential input voltage range Dominant state differential input voltage range	V _{Diff}	V _{th(RX)dif}	differential receiver threshold voltage		
		V _{rec(RX)}	receiver recessive voltage		
		V _{dom(RX)}	receiver dominant voltage		
HS-PMA receiver input resistance (matching)					
Differential internal resistance	R _{Diff}	R _{i(dif)}	differential input resistance		
Single ended internal resistance	R _{CAN_H} R _{CAN_L}	R _i	input resistance		
Matching of internal resistance	MR	ΔR _i	input resistance deviation		
HS-PMA implementation loop delay requirement					
Loop delay	t _{Loop}	t _{d(TXDH-RXDH)}	delay time from TXD HIGH to RXD HIGH		
		$t_{d(TXDL-RXDL)}$	delay time from TXD LOW to RXD LOW		

ISO 11898-2:2016		NXP data sheet			
Parameter	Notation	Symbol	Parameter		
Optional HS-PMA implementation data signal timing requ Mbit/s and above 2 Mbit/s up to 5 Mbit/s	uirements f	for use with bit	rates above 1 Mbit/s up to 2		
Transmitted recessive bit width @ 2 Mbit/s / @ 5 Mbit/s, intended	t _{Bit(Bus)}	t _{bit(bus)}	transmitted recessive bit width		
Received recessive bit width @ 2 Mbit/s / @ 5 Mbit/s	t _{Bit(RXD)}	t _{bit(RXD)}	bit time on pin RXD		
Receiver timing symmetry @ 2 Mbit/s / @ 5 Mbit/s	∆t _{Rec}	∆t _{rec}	receiver timing symmetry		
HS-PMA maximum ratings of $V_{CAN_H},$ V_{CAN_L} and V_{Diff}					
Maximum rating V _{Diff}	V _{Diff}	V _(CANH-CANL)	voltage between pin CANH and pin CANL		
General maximum rating V_{CAN_H} and V_{CAN_L}	V _{CAN_H}	V _x	voltage on pin x		
Optional: Extended maximum rating VCAN_H and VCAN_L	V _{CAN_L}				
HS-PMA maximum leakage currents on CAN_H and CAN	_L, unpow	ered			
Leakage current on CAN_H, CAN_L	I _{CAN_H} I _{CAN_L}	IL	leakage current		
HS-PMA bus biasing control timings					
CAN activity filter time, long	t _{Filter}	t _{wake(busdom)} [1]	bus dominant wake-up time		
CAN activity filter time, short		t _{wake(busrec)}	bus recessive wake-up time		
Wake-up time-out, short	t _{Wake}	t _{to(wake)bus}	bus wake-up time-out time		
Wake-up time-out, long	1				

Table 12. ISO 11898-2:2016 to NXP data sheet parameter conversion...continued

[1] $t_{fltr(wake)bus}$ - bus wake-up filter time, in devices with basic wake-up functionality

19 Appendix: TJx144x/TJx146x/TJF1441 family overview

Table 13. Feature overview of the complete TJx144x/TJx146x/TJF1441 family

	Mode					Supp			Data	-	Addit	ional f	eatures	6		
Device ^[1]	Normal	Standby	Sleep	Silent/Listen-only	Selectable Off	VCC pin	VIO pin	VBAT pin	Up to 5 Mbit/s CAN FD	Up to 8 Mbit/s CAN FD ^[2]	Signal improvement ^[3]	Wake-up source recognition ^[4]	Short WUP support [0.5 - 1.8 µs] ^[5]	Single supply pin wake-up ^[6]	TXD dominant timeout	Local diagnostics via ERR_N pin
TJx1441A	•			•		•	•		•						•	
TJx1441B	•			•		•			•						•	
TJx1441D	•			•	•	•			•						•	
TJF1441A	•			•		•	•		•						[7]	
TJx1442A	•	•				•	•		•				•	•	•	
TJx1442B	•	•				•			•				•		•	
TJx1443A	•	•	•	•		•	•	•	•			•	•	•	•	•
TJx1448A	•	•				•	•		•				•	•	•	
TJx1448B	•	•				•			•				•		•	
TJx1448C	•	•				•	•		•			•	•	•	•	
TJx1462A	•	•				•	•		•	•	•		•	•	•	
TJx1462B	•	•				•			•	•	•		•		•	
TJx1463A	•	•	•	•		•	•	•	•	•	•	•	•	•	•	•

TJx: TJA14xxx is AEC-Q100 Grade 1; TJR14xxx is AEC-Q100 Grade 0; TJF1441A is non-automotive grade. Only guaranteed for TJA146x, AEC-Q100 Grade 1. [1]

[2] [3] [4] [5] CAN FD Signal Improvement Capability (SIC) according to CiA 601-4:2019.

RXD is held LOW after wake-up request, enabling wake-up source recognition.

WUP = wake-up pattern according ISO11898-2:2016.

[6] [7] Only VIO supply needed for wake-up in TJA1442A, TJA1448A, TJA1448C, TJA1462A; only VBAT supply needed for wake-up in TJA1443A, TJA1463A.

Not having TXD dominant timeout allows for very low data rates in non-automotive grade applications.

20 Revision history

Table 14. Revisio	on history							
Document ID	Release date	Data sheet status	Change notice	Supersedes				
TJA1443 v.2	20211015	Product data sheet	-	TJA1443 v.1				
Modifications	 Added device (Table 3) and family (Section 19) feature overviews Figure 3: text defining transition from Sleep to Standy revised Section 7.1.1.2: typo corrected - STBN_N changed to STB_N Table 6: table notes 3 and 4 revised; table note 12 added; measurement conditions and table not changed for parameter V_{trt} Table 9: CAN delay timing characteristics revised; measurement conditions for parameters t_{startup(RXD)} and t_{startup(INH)} revised; table note 8 added Section 21: Suitability for use in Automotive applications and Security disclaimers revised 							
TJA1443 v.1	20200812	Product data sheet	-	-				

21 Legal information

21.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

Please consult the most recently issued document before initiating or completing a design. [1]

The term 'short data sheet' is explained in section "Definitions". [2]

នៃ The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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